


<b>Search Notes</b>  	<b>Application/Control No.</b>  10525564	<b>Applicant(s)/Patent Under Reexamination</b>  KANEMOTO ET AL.
	<b>Examiner</b>  Neff, Michael R	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	145	10/09/07	MN
375	347	10/09/07	MN

SEARCH NOTES		
Search Notes	Date	Examiner
Class/subclass search performed with key word limitations	10/09/07	MN
Non patent literature search performed in IEEE database and with keywords in Google Scholar	10/09/07 & 10/10/07	MN
Met with SPE Shuwang Liu to discuss claims	10/10/07	MN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner